

<b>Notice of References Cited</b>	Application/Control No. 10/598,969		Applicant(s)/Patent Under Reexamination SUTTON ET AL.	
	Examiner SI LEE		Art Unit 4123	Page 1 of 1

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*	C	US-5,372,130	12-1994	Stern et al.	128/205.25
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